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2003. (INZZ) Vibration of flex circuits in hard **disk** drives.

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2002. (INZZ) Write-to-read coupling.

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2000. (INZZ) Measurement and modeling of quasi-rigid-body **modes** in the head actuator assembly.

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1999. (INZZ) Operating characteristics of a same-phase **drive-type** ultrasonic motor using a flexural **disk** vibrator.

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1998. (INZZ) Same-phase **drive-type** small-sized ultrasonic motor using degeneration **modes** of a circular plate.

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1997. (INZZ) Accelerometer feedforward servo for **disk** drives.

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1994. (INZZ) Slider vibrations induced by ramp-suspension interaction during the ramp loading process.

8 [display full document](#)

1986. (INZZ) Flow induced vibration of magnetic head suspension in hard **disk drive**.

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1985. (INZZ) Powertran BBC software.

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1983. (INZZ) Text editing and formatting with WordStar.

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1998. (INZZ) Application of a **temperature** control system to a new hot strip finishing mill.

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1998. (INZZ) Parametric study on the operating efficiencies of a packed bed for **high-temperature** sensible heat storage.

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1996. (INZZ) A **low-temperature** option down to -70 degrees C for a **high-temperature** attachment.

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1985. (INZZ) Effect of design parameters on performance of built-in-storage solar water heaters.

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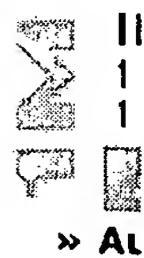
1982. (INZZ) Time-dependent solutions of multimode convection equations.

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1 Evanescently coupled photodiodes integrating a double-stage taper 40-Gb/s applications-compared performance with side-illuminated photodiodes

Demiguel, S.; Giraudet, L.; Joulaud, L.; Decobert, J.; Blache, F.; Coupe, V.; J. F.; Pagnod-Rossiaux, P.; Boucherez, E.; Achouche, M.; Devaux, F.;
Lightwave Technology, Journal of , Volume: 20 , Issue: 12 , Dec. 2002
Pages:2004 - 2014

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2 A DC-100 GHz frequency doubler in InP DHBT technology

Puyal, V.; Konczykowska, A.; Nouet, P.; Bernard, S.; Blayac, S.; Jorge, F.; Riet, M.; Godin, J.;
Microwave Symposium Digest, 2004 IEEE MTT-S International ,Volume: 1 , 6 June 2004
Pages:167 - 170 Vol.1

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3 DFF-drivers ICs for 40 Gb/s ETDM in InP DHBT technology

Konczykowska, A.; Jorge, F.; Riet, M.; Blayac, S.; Moulu, J.; Godin, J.;
Microwave Symposium Digest, 2004 IEEE MTT-S International ,Volume: 1 , 6 June 2004
Pages:113 - 116 Vol.1

[\[Abstract\]](#) [\[PDF Full-Text \(366KB\)\]](#) IEEE CNF

4 Signal to noise ratio enhancement using heterojunction bipolar phototransistor by base current compensation

Dupont, S.; Fendler, M.; Jorge, F.; Maricot, S.; Vilcot, J.-P.; Decoster, D.;
Microwave Photonics, 2000. MWP 2000. International Topical Meeting on , 11- Sept. 2000
Pages:59 - 61

[\[Abstract\]](#) [\[PDF Full-Text \(204KB\)\]](#) IEEE CNF

5 Up-to-50-GHz-clock InP DHBT digital ICs and optical system experiments

Godin, J.; Riet, M.; Blayac, S.; Berdaguer, P.; Dhalluin, V.; Kahn, M.; Kasbari, Puyal, V.; Moulu, J.; Jorge, F.; Vuye, S.; Giraudeau, L.; Franz, B.; Konczykowsk A.;

Gallium Arsenide Integrated Circuit (GaAs IC) Symposium, 2003. 25th Annual Technical Digest 2003. IEEE , 9-12 Nov. 2003

Pages:173 - 176

[\[Abstract\]](#) [\[PDF Full-Text \(448KB\)\]](#) [IEEE CNF](#)

6 Design and measurement of very high bitrate digital ICs fabricated in InP HBT technology

Konczykowska, A.; Blayac, S.; Jorge, F.; Riet, M.; Puyal, V.; Godin, J.;
Microwave Symposium Digest, 2003 IEEE MTT-S International ,Volume: 2 , 8 June 2003

Pages:1177 - 1180 vol.2

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7 40 Gbit/s high performances GaAs pHEMT high voltage modulator driver for long haul optical fiber communications

Mouzannar, W.; Jorge, F.; Vuye, S.; Dutisseuil, E.; Lefevre, R.;
Gallium Arsenide Integrated Circuit (GaAs IC) Symposium, 2002. 24th Annual Technical Digest , 20-23 Oct. 2002

Pages:163 - 166

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8 40 Gbit/s reshaping amplifier cell

Melian, C.; Mouzannar, W.; Jorge, F.; Lefevre, R.;
Electron Devices for Microwave and Optoelectronic Applications, 2001 International Symposium on , 15-16 Nov. 2001
Pages:331 - 334

[\[Abstract\]](#) [\[PDF Full-Text \(266KB\)\]](#) [IEEE CNF](#)

9 44 Gbit/s PSBT/DPSK precoder based on very wideband static divider InP DHBT technology

Konczykowska, A.; Puyal, V.; Jorge, F.; Godin, J.;
Electronics Letters ,Volume: 40 , Issue: 18 , 2 Sept. 2004
Pages:1146 - 1147

[\[Abstract\]](#) [\[PDF Full-Text \(273KB\)\]](#) [IEE JNL](#)

10 High-sensitivity decision circuit in InP/InGaAs DHBT technology and 40-80 Gbit/s optical experiments

Konczykowska, A.; Jorge, F.; Kasbari, A.; Idler, W.; Giraudeau, L.; Schuh, K.; Junginger, B.; Godin, J.;
Electronics Letters ,Volume: 39 , Issue: 21 , 16 Oct. 2003
Pages:1532 - 1533

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11 High quality 80Gbit/s InP DHBT selector and its use for NRZ-RZ conversion

Konczykowska, A.; Andre, P.; Jorge, F.; Godin, J.;
Electronics Letters , Volume: 39 , Issue: 1 , 9 Jan. 2003
Pages:49 - 51

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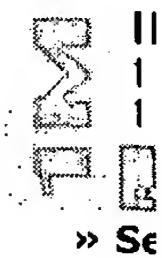
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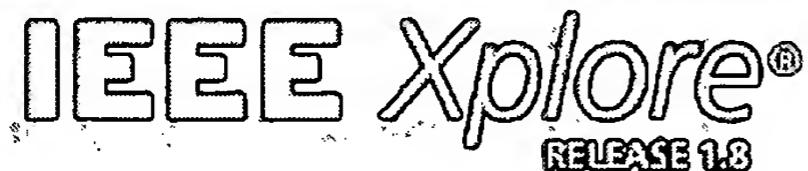
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In:

And

In:

And

In:

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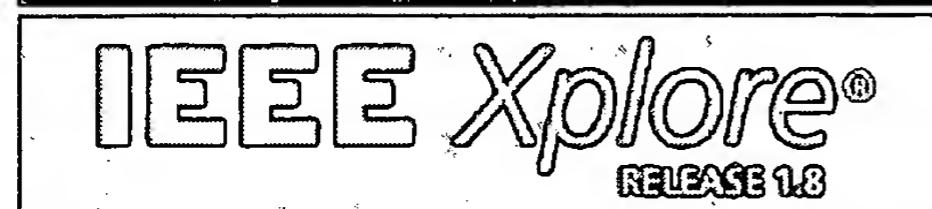
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In:

And

In:

And

In:

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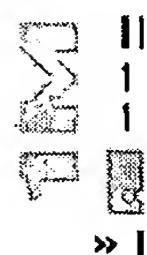


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Select years to search:

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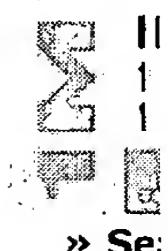
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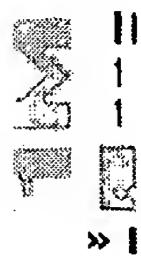


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In:

And

In:

And

In:

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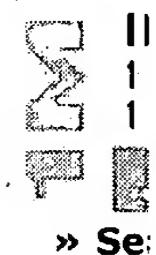
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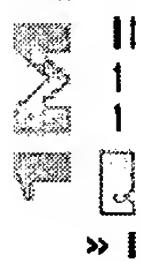


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(disk <phrase> drive) In: All Fields

And

(temperature <phrase>) In: All Fields

And

 In: All Fields

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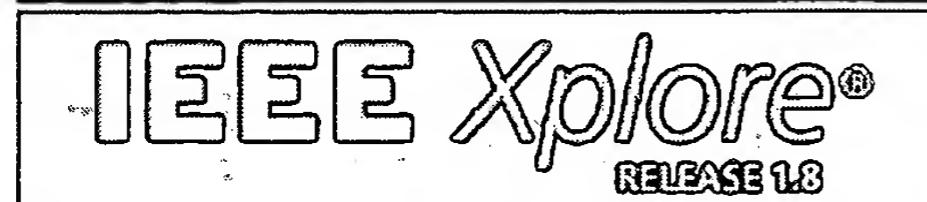
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And

In:

And

In:

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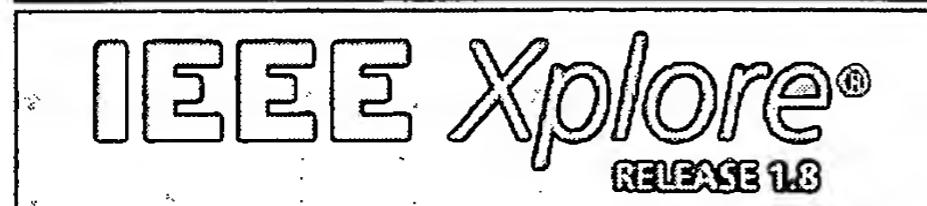
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(hard <phrase> disk < In: All Fields

And

(operation <phrase> n In: All Fields

And

(temperature <phrase> In: All Fields

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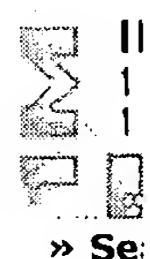
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